Membership   Publications/Services   Standards   Conferences   Careers/Jobs

IEEE Xplore®
RELEASE 1.4

Welcome
United States Patent and Trademark Of

Help   FAQ   Terms   IEEE Peer Review   Quick Links ▼   » Sea

Welcome to IEEE Xplore*

- Home
- What Can I Access?
- Log-out

Tables of Contents

- Journals & Magazines
- Conference Proceedings
- Standards

Search

- By Author
- Basic
- Advanced

Member Services

- Join IEEE
- Establish IEEE Web Account
- Access the IEEE Member Digital Library

🖨 Print Format

Your search matched **7** of **902124** documents.

A maximum of **7** results are displayed, **25** to a page, sorted by **Relevance** in **descending** order.
You may refine your search by editing the current search expression or entering a new one the text b
Then click **Search Again**.

((expert system and design and error and cause) and ((1950 <in> py) or (1951 <in> py))o

Search Again

Results:
Journal or Magazine = **JNL**   Conference = **CNF**   Standard = **STD**

---

1 **A knowledge-based SPICE environment for improved convergence an friendliness**
Kelessoglu, T.M.; Pederson, D.O.;
Custom Integrated Circuits Conference, 1988., Proceedings of the IEEE 1988 , 1 May 1988
Page(s): 3.1/1 -3.1/4

[Abstract]   [PDF Full-Text (252 KB)] **IEEE CNF**

---

2 **A connectionist system for ATM signalling analysis**
Ginkou Ma; Jiann-Liang Chen; Lin, B.-S.P.;
Global Telecommunications Conference, 1994. GLOBECOM '94. 'Communication Global Bridge'., IEEE , Volume: 3 , 28 Nov- 2 Dec 1994
Page(s): 1839 -1844 vol.3

[Abstract]   [PDF Full-Text (364 KB)] **IEEE CNF**

---

3 **An expert fault manager using an object meta-model**
Barnett, B.; Crapo, A.;
Local Computer Networks, 1995., Proceedings. 20th Conference on , 16-19 Oct
Page(s): 227 -234

[Abstract]   [PDF Full-Text (548 KB)] **IEEE CNF**

---

4 **Implements a diagnostic intelligent agent for problem solving in instructional systems**
Chang, J.; Chang, M.; Jeng-Lun Lin; Jai-Sheng Heh;
Advanced Learning Technologies, 2000. IWALT 2000. Proceedings. Internationa

Workshop on , 2000
Page(s): 29 -30

[Abstract] [PDF Full-Text (184 KB)] **IEEE CNF**

5 **NECTAR: a knowledge-based environment to enhance SPICE**
Kelessoglou, T.M.; Pederson, D.O.;
Solid-State Circuits, IEEE Journal of , Volume: 24 Issue: 2 , Apr 1989
Page(s): 452 -457

[Abstract] [PDF Full-Text (504 KB)] **IEEE JRN**

6 **DESPLATE: an expert system for abnormal shape diagnosis in the pla**
Ng, T.S.; Cung, L.D.; Chicharo, J.F.;
Industry Applications, IEEE Transactions on , Volume: 26 Issue: 6 , Nov/Dec 19
Page(s): 1057 -1062

[Abstract] [PDF Full-Text (580 KB)] **IEEE JRN**

7 **Incorporating probabilistic reasoning in a reactive program debuggin
system**
Burnell, L.J.; Talbot, S.E.;
Expert, IEEE [see also IEEE Intelligent Systems] , Volume: 9 Issue: 1 , Feb 199
Page(s): 15 -20

[Abstract] [PDF Full-Text (628 KB)] **IEEE JRN**

Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search
Join IEEE | Web Account | New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting
No Robots Please | Release Notes | IEEE Online Publications | Help | FAQ| Terms | Back to Top

IEEE HOME | SEARCH IEEE | SHOP | WEB ACCOUNT | CONTACT IEEE

Membership   Publications/Services   Standards   Conferences   Careers/Jobs

IEEE Xplore®
RELEASE 1.4

Welcome
United States Patent and Trademark Of

Help   FAQ   Terms   IEEE Peer
Review

Quick Links

» Sea

Welcome to IEEE Xplore®

◯ Home
◯ What Can
    I Access?
◯ Log-out

Tables of Contents

◯ Journals
    & Magazines
◯ Conference
    Proceedings
◯ Standards

Search

◯ By Author
◯ Basic
◯ Advanced

Member Services

◯ Join IEEE
◯ Establish IEEE
    Web Account
◯ Access the
    IEEE Member
    Digital Library

🖶 Print Format

Your search matched **6** of **903905** documents.

A maximum of **6** results are displayed, **25** to a page, sorted by **Relevance** in **descending** order.
You may refine your search by editing the current search expression or entering a new one the text b
Then click **Search Again**.

hekmatpour

Search Again

Results:
Journal or Magazine = **JNL**   Conference = **CNF**   Standard = **STD**

---

1 **KINDEN: knowledge-based INtelligent VLSI design ENvironment**
Hekmatpour, A.; Chau, P.;
AI Systems in Government Conference, 1990. Proceedings., Fifth Annual , 6-11
1990
Page(s): 96 -103

[Abstract]   [PDF Full-Text (780 KB)] **IEEE CNF**

---

2 **KINFIDA: an object-oriented model-based digital filter design assista**
Hekmatpour, A.; Power, S.; Chau, P.;
Acoustics, Speech, and Signal Processing, 1990. ICASSP-90., 1990 Internation
Conference on , 3-6 Apr 1990
Page(s): 1069 -1072

[Abstract]   [PDF Full-Text (420 KB)] **IEEE CNF**

---

3 **Categorization-based diagnostic problem solving in the VLSI design d**
Hekmatpour, A.; Elkan, C.;
Artificial Intelligence for Applications, 1993. Proceedings., Ninth Conference on
Mar 1993
Page(s): 121 -127

[Abstract]   [PDF Full-Text (644 KB)] **IEEE CNF**

---

4 **A multimedia expert system for wafer polisher maintenance**
Hekmatpour, A.; Elkan, C.;
Artificial Intelligence for Applications, 1993. Proceedings., Ninth Conference on
Mar 1993

Page(s): 453

[Abstract]   [PDF Full-Text (100 KB)] **IEEE CNF**

5 **An approach to automated software design based on product metrics**
Ince, D.C.; Hekmatpour, S.;
Software Engineering Journal , Volume: 3 Issue: 2 , Mar 1988
Page(s): 53 -56

[Abstract]   [PDF Full-Text (644 KB)] **IEE JRN**

6 **Hierarchical modeling of the VLSI design process**
Hekmatpour, A.; Orailoglu, A.; Chau, P.;
Expert, IEEE [see also IEEE Intelligent Systems] , Volume: 6 Issue: 2 , Apr 199
Page(s): 56 -70

[Abstract]   [PDF Full-Text (2056 KB)] **IEEE JRN**

Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search
Join IEEE | Web Account | New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting
No Robots Please | Release Notes | IEEE Online Publications | Help | FAQ| Terms | Back to Top